

**Search Notes**

Application No.

10/064,667

Examiner

Thao P Le

Applicant(s)

HSU ET AL.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
438	211	8/7/2003	T.LE
438	257	8/7/2003	T.LE
438	267	8/7/2003	T.LE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	315	8/7/2003	T.Le

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
flash memory split gate spacer control gate, floating gate source/drain etching	8/7/2003	T.LE
select gate	8/7/2003	T.Le